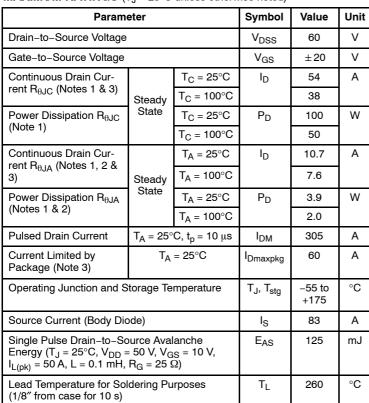
Power MOSFET

60 V, 17 m Ω , 54 A, Single N–Channel Logic Level, DPAK

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- High Current Capability
- Avalanche Energy Specified
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)



Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain)	$R_{\theta JC}$	1.5	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	38	

 The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

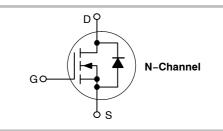
3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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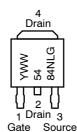
V _{(BR)DSS}	R _{DS(on)}	I _D
60 V	17 m Ω @ 10 V	54 A
	23 mΩ @ 4.5 V	34 A





DPAK CASE 369AA STYLE 2

MARKING DIAGRAMS & PIN ASSIGNMENT



Y = Year WW = Work Week 5484NL = Device Code G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	1		L		•		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA		60			V
Zero Gate Voltage Drain Current			T _J = 25°C			1.0	μA
		$V_{\rm DS} = 60 \text{ V}$	T _J = 125°C			10	-
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 4)	1		L		•		
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = 250 μA		1.5	1.9	2.5	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 25 A			13.5	17	mΩ
		V _{GS} = 4.5 V, I	_D = 25 A		18	23	1
Forward Transconductance	9 FS	V _{DS} = 15 V, I _D = 20 A			41		S
CHARGES AND CAPACITANCES	•				•		
Input Capacitance	C _{iss}	$V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = 25 V$			1410		pF
Output Capacitance	C _{oss}				315		1
Reverse Transfer Capacitance	C _{rss}				135		
Total Gate Charge	Q _{G(TOT)}	V _{DS} = 48 V, I _D = 23 A	V _{GS} = 4.5 V		27		nC
			V _{GS} = 10 V		48		
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 10 \text{ V}, \text{ V}_{DS} = 48 \text{ V},$ $I_D = 23 \text{ A}$			0.9		1
Gate-to-Source Charge	Q _{GS}				4.4		
Gate-to-Drain Charge	Q _{GD}				19		
Gate Resistance	R _G				8.5		Ω
SWITCHING CHARACTERISTICS (Not	e 5)						
Turn-On Delay Time	t _{d(on)}				18		ns
Rise Time	t _r	V _{GS} = 4.5 V, V _E	ve = 48 V		160		1
Turn-Off Delay Time	t _{d(off)}	$I_{\rm D} = 23 \rm{A}, R_{\rm G}$	= 10 Ω		100		1
Fall Time	t _f	4			110		1
Turn–On Delay Time	t _{d(on)}	V_{GS} = 10 V, V_{DS} = 48 V, I_{D} = 23 A, R_{G} = 10 Ω			7.8		1
Rise Time	t _r				45		1
Turn-Off Delay Time	t _{d(off)}				152		1
Fall Time	t _f				113		1
DRAIN-SOURCE DIODE CHARACTER	RISTICS				•		
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V,$ $I_{S} = 25 A$	T _J = 25°C		0.9	1.2	V
			T _J = 125°C		0.8		1
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dls/dt = 100 A/μs, I _S = 23 A			64		ns
Charge Time	ta				33		1
	1				1		4

Reverse Recovery Charge

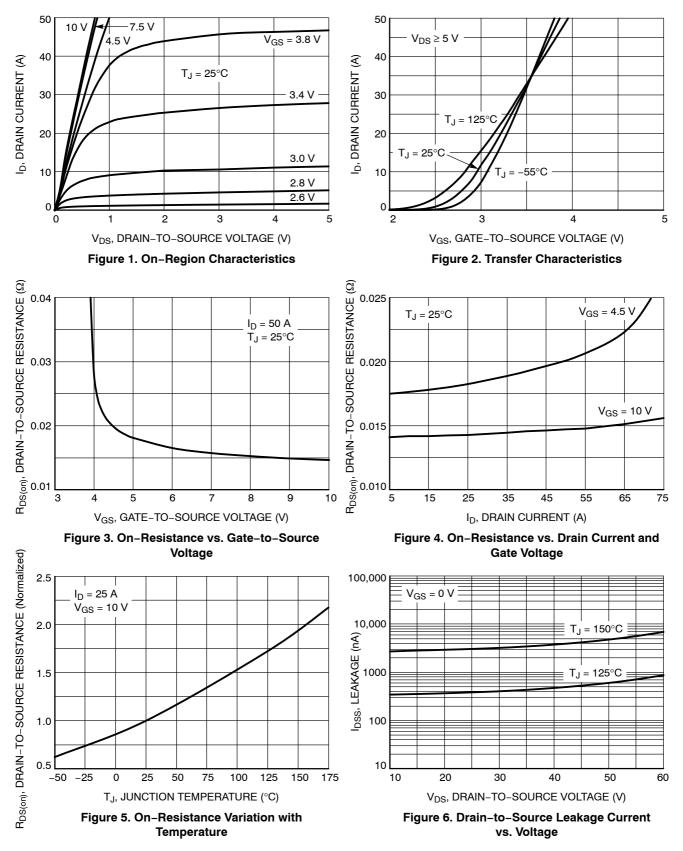
Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

Q_{RR}

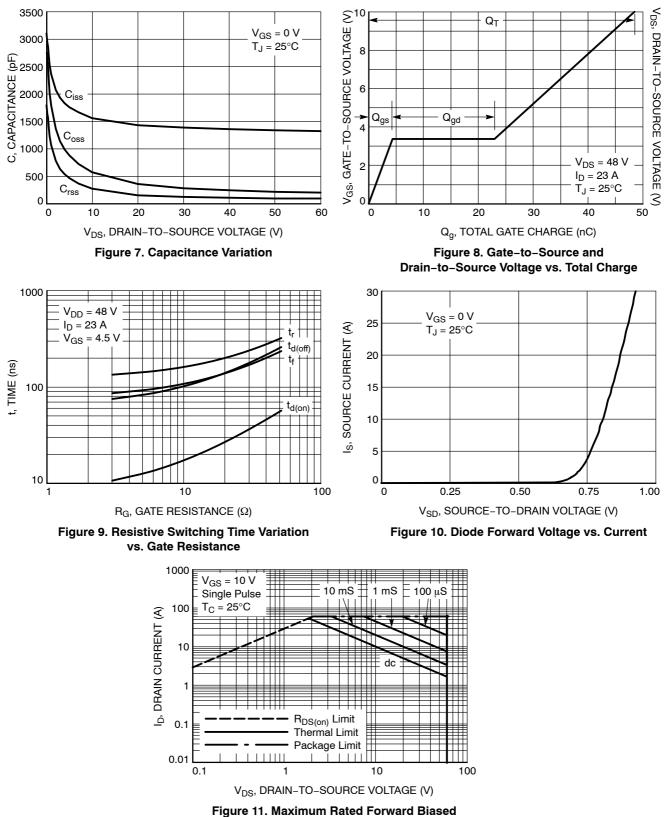
118

nC

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



Safe Operating Area

TYPICAL CHARACTERISTICS

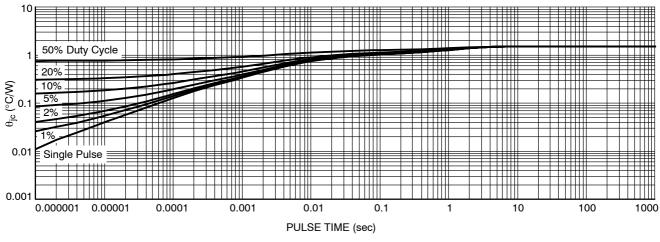


Figure 12. Thermal Response

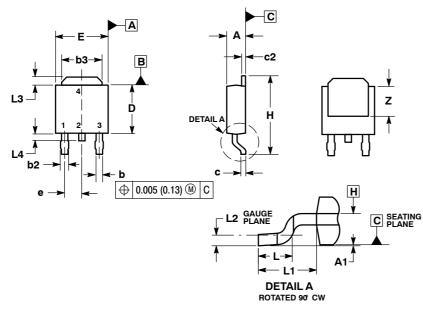
ORDERING INFORMATION

Order Number	Package	Shipping [†]
NVD5484NLT4G	DPAK (Pb–Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK CASE 369AA ISSUE B

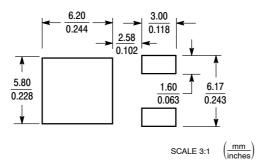


NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14 5M 1994
- Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
- MENSIONS DO, LS AND E. DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 DATUMS A AND B ARE DETERMINED AT DATUM

	INCHES		MILLIMETER	
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090 BSC		2.29 BSC	
н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74 REF	
L2	0.020	BSC	0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Ζ	0.155		3.93	

SOLDERING FOOTPRINT*



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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